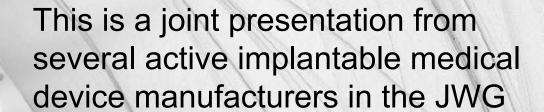
Implantable Device Industry Perspective on Fixed Parameter Modes

Partnering for Safe MRI Access



Boston Scientific St. Jude Medical Medtronic





Overview

- Shared Patients, Shared Need
 - Goal: Safe MRI access for patients with implantable devices
- Existing MRI safety regulations limit exposure fields based on human physiologic response. Each MRI manufacturer uses proprietary algorithms to adhere to these limits.
- The resulting uncertainty in field levels makes device testing and regulatory approvals very challenging
- Proposed solution: Develop industry wide scanner modes that limit EM field levels to well defined values.
- JWG and MT40 are discussing establishing fixed modes
- AIMD community requests input and support from FDA, MRI Technologists, Radiologists, and MRI Manufacturers







Motivation for MRI Access: Patient and Clinical Perspective

- Increasing patient population with IMDs
 - Passive: hip/knee replacements, stents, heart valves, etc.
 - Active: pacemakers/defibrillators, neurostimulators, drug pumps, etc.

More Patients, Living Longer

- Increasing diagnostic indications with MRI as gold standard
 - Many IMD patients have MRI on pathway to implant
 - Majority of IMD patients will later need MRI

Increasing Value of MRI Exams

- Scanning patients with MR Conditional IMDs
 - Scanning an MRI conditional patient is complex
 - Fixed parameter modes will help this issue

Patient
Pathway to
MRI



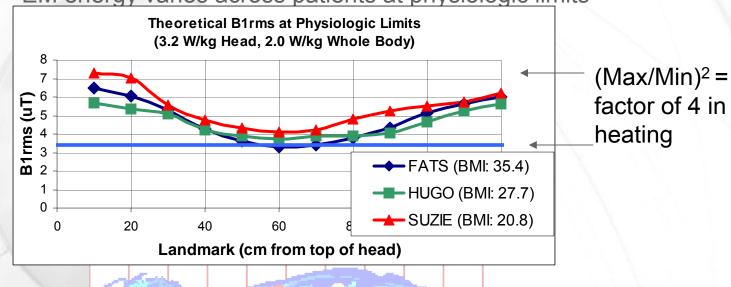




Physiologic MRI limits

- Existing limits focus on physiologic response but do not directly limit the EM energy within the MRI
 - SAR (W/kg)
 - PNS threshold (% of patient threshold)

EM energy varies across patients at physiologic limits









Need for Fixed EM Modes

- Existing limits are implemented using inconsistent and proprietary methods across MRI manufacturers
- Presents significant testing and labeling challenges for AIMD manufacturers and regulators
 - Must determine each MR manufacturers implementation
 - MR manufacturers can change implementation over time
 - May force evaluation at extreme non-clinical levels
 - Potentially requires more MRI conditions in labeling
- Fixed modes add clarity to the levels at which devices are to be tested







Device-Critical Parameters

 AIMD agreed device-critical EM parameters on which to standardize MRI output

EM Parameters	Potential Hazard
Peak RF power (B _{1peak} uT)	Device Damage/EMI
Average RF power (B1 _{rms} uT)	Lead Heating
Peak gradient switching fields (dB/dt _{peak} T/s)	Unintended Stimulation/EMI
Average gradient switch fields (dB/dt _{rms} T/s)	Device Heating







Fixed Parameter Mode(s)

- Defines environment
- Enables:
 - Accurate device characterization
 - Streamlined and consistent approval by regulators
 - Increased MRI access
- Defines a consistent implementation across MR systems







JWG Progress

- Collaboration of AIMD, MRI, regulatory, and academia members
 - Goal: Improve AIMD MRI testing and labeling
- Completed 1st edition of ISO/TS 10974
 - Standardize and improve AIMD/MRI testing, assuming field levels are known
- JWG AIMD participants submitted proposal of fixed modes to MT40
 - Short term: Single mode for 1.5T
 - Long term: Multiple modes for 1.5T and 3T
- Status: MT40 is considering single mode for 1.5T
 - Refined and agreed upon B1rms and B1peak
 - Discussing dB/dt levels
 - We acknowledge that this may require a substantial amount of work by MRI manufacturers
- We ask for support and input to the fixed modes from the FDA, MRI Technologists, Radiologists, MRI Manufacturers







1.5T Fixed Parameter Values in Discussion with MT40

EM Parameters	Parameter Values
Peak RF power (B _{1peak} uT)	30 uT
Average RF power (B1 _{rms} uT)	3.2 uT
Peak gradient switching fields (dB/dt _{peak} T/s)	80 T/s
Average gradient switch fields (dB/dt _{rms} T/s)	56 T/s

- This set of parameters provides fixed limits with MR performance near Normal Operating Mode
- A similar proposal for 3T was also made







Conclusions

- Current physiologic limits lead to a varying environment that complicate testing and regulatory submissions
- Directly limiting the EM energy provides
 - A defined environment
 - Avenue for simplified testing and labeling
 - Improved access to MR scans
- JWG and MT40 are discussing fixed exposure limits but additional effort is needed to finalize and implement







Acronyms

AIMD: Active implantable medical device

EM: Electromagnetic

JWG: Joint working group

IEC: International Electrotechnical Commission

IMD: Implantable medical device

ISO: International Organization for Standardization

MR: Magnetic resonance

MRI: Magnetic resonance imaging

MT40: IEC subcommittee 62 B maintenance team 40:

Magnetic resonance equipment for medical

diagnosis

PNS: Peripheral nerve stimulation

SAR: Specific absorption rate

TS: Technical specification





